

FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)  Date Submitted to PTO: <b>July 18, 2002</b>		ATTY DOCKET NO. <b>00862.022502</b>		APPLICATION NO. <b>10/052,464</b>	
APPLICANT <b>Keiichi IWAMURA</b>		FILING DATE <b>January 23, 2002</b>		GROUP <b>2131</b>	

  

U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
						<div style="font-size: 2em; font-weight: bold;">RECEIVED</div> <div style="font-size: 1.2em;">JUL 23 2002</div> <div style="font-size: 1.2em;">Technology Center 2100</div>
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

  

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	
38	"Blind Digital Fingerprinting", Iwamura, et al., IEICE Transactions ISEC97-35, 09-1997, pp. 63-74 (English Translation enclosed)
35	"Secure Digital Watermarking Systems for Secondary Distribution" Iwamura, et al., SCIS' 98-10.2F, 01-1998, pp. 1 to 8 (English Translation enclosed)

  

EXAMINER <i>Elev Stigs</i>	DATE CONSIDERED <i>8/24/05 - 8/26/05</i>
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.

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FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE  PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S)  (Use several sheets if necessary)  Date Submitted to PTO: <b>May 16, 2002</b>		ATTY DOCKET NO.  <b>00862.022502</b>	APPLICATION NO.  <b>10/052,464</b>
		<b>RECEIVED</b> <b>MAY 20 2002</b>	
		APPLICANT  <b>Keiichi IWAMURA</b>	
		FILING DATE  <b>January 23, 2002</b>	GROUP <b>Technology Center 2100 2131</b>

  

U.S. PATENT DOCUMENTS							
*EXAMINER	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block;">             OIPE              MAY 16 2002              PATENT &amp; TRADEMARK OFFICE           </div>							
		6,088,454	07/2000	Nagashima, et al.	380	49	
		5,937,395	08/1999	Iwamura	705	30	
		5,666,419	09/1997	Yamamoto, et al.	380	28	
		5,636,292	06/1997	Rhodes	382	232	
	5,600,720	02/1997	Iwamura, et al.	380	1		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
ES	"Storage and Retrieval for Image and Video Databases IIP" W. Niblack, et al., PROCEEDINGS SPIE-The International Society for Optical Engineering, Feb. 9-10, 1995, San Jose, CA, Vol 2420, pps. 164-173						
ES	"A Method of Watermarking under Frequency Domain for Protecting Copyright of Digital Image" T. Nakamura, et al., SCIS'97, The 1997 Symposium on Cryptography and Information Security, Fukuoka, Japan, Jan. 29-Feb. 1, 1997, The Institute of Electronics, Information and Communication Engineers, three pages (including English Abstract)						
ES	"A Digital Watermark Based on the Wavelet Transform and its Robustness on Image Compression", H. Inoue, et al., Proceedings of SCIS '98, January 29, 1998, IEEE, pps. 391-395						
ES	"A watermarking scheme to image data by PN sequence" J. Ohnishi, et al., SCIS'97, The 1997 Symposium on Cryptography and Information Security, Fukuoka, Japan, Jan. 29-Feb. 1, 1997, The Institute of Electronics, Information and Communication Engineers, pps. 1-8						
ES	"A Digital Watermark Technique Based on the Wavelet Transform and Its Robustness on Image Compression and Transformation" H. Inoue, et al., Special Section on Cryptography and Information Security, IEICE Trans. Fundamentals, Vol. E82-A, No. 1 January 1999, pps. 2-10						
ES	"On an experimental evaluation of steganography with wavelet transform" H. Ishizuka, et al., SCIS'97, The 1997 Symposium on Cryptography and Information Security, Fukuoka, Japan, Jan. 29-Feb. 1, 1997, The Institute of Electronics, Information and Communication Engineers, pps. 1-10						
EXAMINER <div style="font-family: cursive; font-size: 1.5em;">Els Shif</div>			DATE CONSIDERED <div style="font-family: cursive; font-size: 1.5em;">8/22/05 - 8/26/05</div>				

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